ATTACHMENT 1(a)

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LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

ATTORNEY DOCKET NO.	APPLICATION NO.				
0001.1045	10/529,044				
FIRST NAMED INVENTOR					
Joo-Ho KIM et al.					
FILING DATE	GROUP ART UNIT				
March 24 2005	1794				

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
/KB/	AA	2001/0015949	8/23/2001	Nagase et al		ASSESSED	and the second
/KB/	AB	6,411,591	6/25/2002	Moritani et al		Market Ma	
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	AE				designation		

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		DOCUMENT NO.	DATE	COUNTRY	TRANSL	ATION NO	ABSTRACT
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200500000000000000000000000000000000000	ÅH						

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/KB/	Al	Supplementary European Search Report issued April 3, 2008 by the European Patent Office re: European Patent Application No. 0379854.3 (4 pp)		
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EXAMINER	DATE CONSIDERED			
/Kevin Bernatz/	09/22/2008			
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.